

<p style="text-align: center;"><b>Notic of References Cited</b></p>	Application/Control No. 10/801,567	Applicant(s)/Patent Under Reexamination YOSHIKAWA, NORIO	
	Examiner Matthew G. Kayrish	Art Unit 2627	Page 1 of 1

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*	B	US-2002/0044375	04-2002	Hirasaka et al.	360/97.01
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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